PART "B"

U.S. Department of Commerce, Patent and Trademark Office	Atty. Docket No.	Serial No.
	01N006-1C US	09/849,005
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Applicants: Chian-Min Ho et al.	
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RF	AB	5,630,051	5/13/97	Sun et al.	395	183.08	
RF	AC	5,600,787	2/4/97	Underwood et al.	395	183.06	
RF	AD	5,623,499	4/22/97	Ko et al.	371	22.1	
RF	AE	5,654,657	8/5/97	Pearce	327	163	
RF	AF	5,729,554	3/17/98	Weir et al.	371	27	

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RF	AL	Keutzer, K., "The Need for Formal Verification in Hardware Design and What Formal Verification Has Note Done for Me Lately", Workshop on the HOL Theorem Proving System and its Application, 1991, pp. 77-86.
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PART "B"

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